

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China

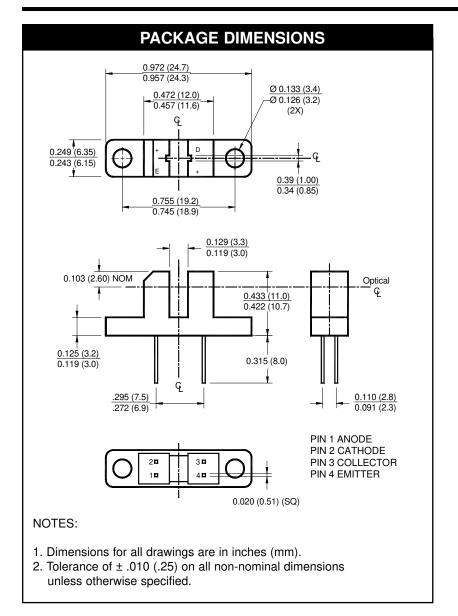


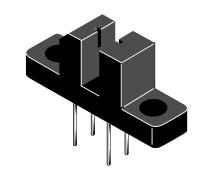


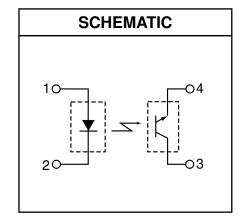




H21A4 H21A5 H21A6







DESCRIPTION

The H21A series are gallium arsenide infrared emitting diode coupled with a silicon photodarlington in a plastic housing. The packaging system is designed to optimize the mechanical resolution, coupling efficiency, ambient light rejection, cost and reliability. The gap in the housing provides a means of interrupting the signal with an opaque material, switching the output from an "ON" to an "OFF" state.

FEATURES

- · Opaque housing
- Low cost
- · .035" apertures
- High I_{C(ON)}



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Parameter	Symbol	Rating	Unit	
Operating Temperature	T _{OPR}	-55 to +100	°C	
Storage Temperature	T _{STG}	-55 to +100	°C	
Soldering Temperature (Iron)(2,3 and 4)	T _{SOL-I}	240 for 5 sec	°C	
Soldering Temperature (Flow)(2 and 3)	T _{SOL-F}	260 for 10 sec	°C	
INPUT (EMITTER)	1_	50	1	
Continuous Forward Current	lF	50	mA	
Reverse Voltage	V _R	6	V	
Power Dissipation (1)	P _D	100	mW	
OUTPUT (SENSOR)	V		V	
Collector to Emitter Voltage	V _{CEO}	55	V	
Emitter to Collector Voltage	V _{ECO}	4.5	V	
Collector Current	I _C	20	mA	
Power Dissipation (T _C = 25°C) ⁽¹⁾	P _D	150	mW	

NOTE:

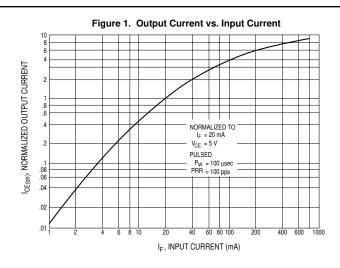
- 1. Derate power dissipation linearly 1.67 mW/°C above 25°C.
- 2. RMA flux is recommended.
- 3. Methanol or isopropyl alcohols are recommended as cleaning agents.
- 4. Soldering iron tip 1/16" (1.6mm) minimum from housing.

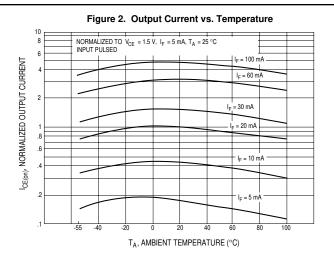
ELECTRICAL / OPTICAL CHARACTERISTICS (TA =25°C) (All measurements made under pulse conditions)										
PARAMETER	TEST CONDITIONS	SYMBOL	DEVICES	MIN	TYP	MAX	UNITS			
INPUT (EMITTER) Forward Voltage	I _F = 60 mA	VF	All	_	_	1.7	V			
Reverse Breakdown Voltage	$I_R = 10 \mu A$	V_R	All	6.0	_	_	μΑ			
Reverse Leakage Current	V _R = 3 V	I _R	All	_	1	1.0	μΑ			
OUTPUT (SENSOR) Emitter to Collector Breakdown	$I_F = 100 \mu A, Ee = 0$	BV_ECO	All	6.0		_	V			
Collector to Emitter Breakdown	$I_{\rm C} = 1 \text{ mA}, Ee = 0$	BV_CEO	All	55	_	_	V			
Collector to Emitter Leakage	$V_{CE} = 45 \text{ V, Ee} = 0$	I_{CEO}	All	_	1	100	nA			
COUPLED On-State Collector Current	$I_F = 5 \text{ mA}, V_{CE} = 5 \text{ V}$	$I_{C(ON)}$	H21A4 H21A5 H21A6	0.15 0.30 0.60			mA			
	I _F = 20 mA, V _{CE} = 5 V		H21A4 H21A5 H21A6	1.0 2.0 4.0	_ 					
	$I_F = 30 \text{ mA}, V_{CE} = 5 \text{ V}$		H21A4 H21A5 H21A6	1.9 3.0 5.5	_ 	_ 				
Saturation Voltage	$I_F = 20 \text{ mA}, I_C = 1.8 \text{ mA}$ $I_F = 30 \text{ mA}, I_C = 1.8 \text{ mA}$	VCE(SAT)	H21A5/6 H21A4	— —	_	0.40 0.40	V V			
Turn-On Time	$I_F = 30$ mA, $V_{CC} = 5$ V, $R_L = 2.5$ K Ω	t _{on}	All		8	_	μs			
Turn-Off Time	$I_F = 30 \text{ mA}, V_{CC} = 5 \text{ V}, R_L = 2.5 \text{ K}\Omega$	t _{off}	All	_	50	_	μs			

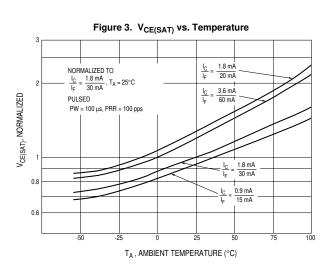


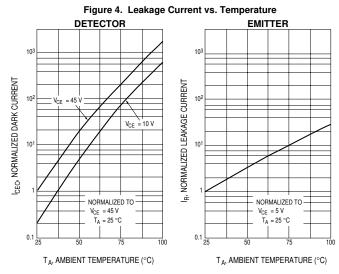
H21A4 H21A5 H21A6

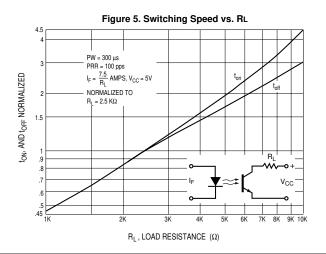
TYPICAL PERFORMANCE CURVES

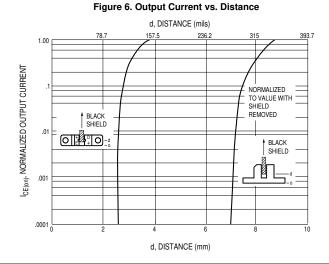














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